

## S-8269B Series

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# OVERCURRENT MONITORING IC FOR MULTI-SERIAL-CELL PACK

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The S-8269B Series is an overcurrent monitoring IC for multi-serial-cell pack including high-accuracy voltage detection circuits and delay circuits.

By using an external overcurrent detection resistor, the S-8269B Series realizes high-accuracy overcurrent protection with less effect from temperature change.

#### **■** Features

• High-accuracy voltage detection circuit

• Detection delay times are generated only by an internal circuit (external capacitors are unnecessary)

• Discharge overcurrent control function

Release condition of discharge overcurrent status: Load disconnection

Release voltage of discharge overcurrent status:  $V_{DIOV1}$ ,  $V_{RIOV} = V_{DD} \times 0.8$  (typ.)

High-withstand voltage:
VM pin and CO pin: Absolute maximum rating 28 V

Low current consumption

During operation: 2.0  $\mu$ A typ., 4.0  $\mu$ A max. (Ta = +25°C)

• Wide operation temperature range: Ta = -40°C to +85°C

• Lead-free (Sn 100%), halogen-free

## ■ Applications

· Lithium-ion rechargeable battery pack

• Lithium polymer rechargeable battery pack

## ■ Package

• SNT-6A

## **■** Block Diagram

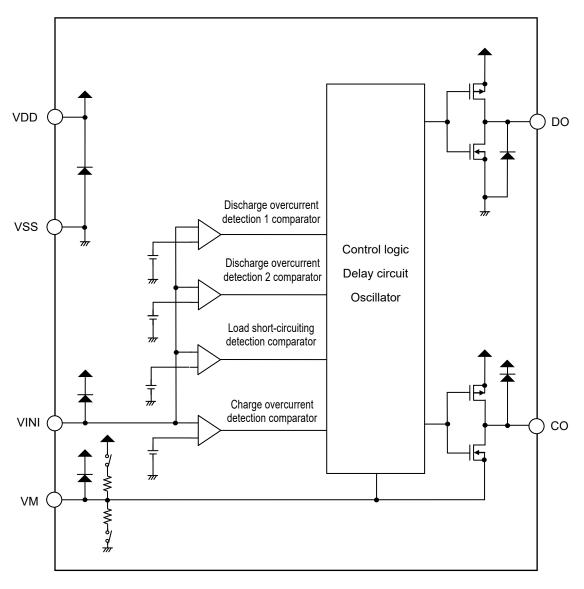
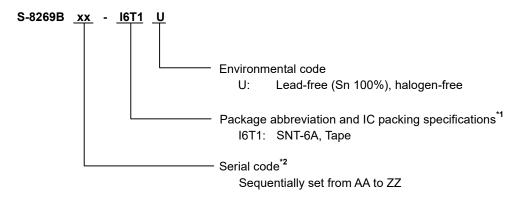


Figure 1

#### **■ Product Name Structure**

#### 1. Product name



- \*1. Refer to the tape drawing.
- \*2. Refer to "3. Product name list".

## 2. Package

**Table 1 Package Drawing Codes** 

Package Name	Dimension	Tape	Reel	Land
SNT-6A	PG006-A-P-SD	PG006-A-C-SD	PG006-A-R-SD	PG006-A-L-SD

#### 3. Product name list

Table 2

				Tub					
	Discharge	Discharge	Load Short-	Charge	Discharge	Discharge	Load Short-	Charge	Release
	Overcurrent	Overcurrent	circuiting	Overcurrent	Overcurrent	Overcurrent	circuiting	Overcurrent	Voltage of
Product Name	Detection	Detection	Detection	Detection	Detection	Detection	Detection	Detection	Discharge
	Voltage 1	Voltage 2	Voltage	Voltage	Delay Time1	Delay Time2	Delay Time	Delay Time	Overcurrent
	[V <sub>DIOV1</sub> ]	[V <sub>DIOV2</sub> ]	[V <sub>SHORT</sub> ]	[Vciov]	[t <sub>DIOV1</sub> ]	[t <sub>DIOV2</sub> ]	[tshort]	[tciov]	Status*1, 2
S-8269BAA-I6T1U	0.0300 V	0.060 V	0.100 V	-0.0300 V	4.0 s	8 ms	280 μs	8 ms	Vriov
S-8269BAB-I6T1U	0.0600 V	0.080 V	0.100 V	-0.0150 V	512 ms	128 ms	530 μs	128 ms	V <sub>DIOV1</sub>
S-8269BAC-I6T1U	0.0300 V	0.050 V	0.075 V	-0.0050 V	256 ms	8 ms	280 μs	128 ms	V <sub>DIOV1</sub>
S-8269BAD-I6T1U	0.0350 V	0.055 V	0.100 V	-0.015 V	2.0 s	32 ms	280 μs	128 ms	VRIOV

<sup>\*1.</sup> Release voltage of discharge overcurrent status:  $V_{DIOV1}$ ,  $V_{RIOV} = V_{DD} \times 0.8$  (typ.)

**Remark** Please contact our sales representatives for products other than the above.

Table 3

Tuble								
Delay Time	Symbol		Selection Range					Remark
Discharge overcurrent detection	4	8 ms	16 ms	32 ms	64 ms	128 ms	256 ms	Select a value
delay time 1	t <sub>DIOV1</sub>	512 ms	1.0 s	2.0 s	3.0 s	3.75 s	4.0 s	from the left.
Discharge overcurrent detection delay time 2	t <sub>DIOV2</sub>	4 ms	8 ms	16 ms	32 ms	64 ms	128 ms	Select a value from the left.
Load short-circuiting detection delay time	tshort	280 μs	530 μs	ı	_	_	_	Select a value from the left.
Charge overcurrent detection delay time	tciov	4 ms	8 ms	16 ms	32 ms	64 ms	128 ms	Select a value from the left.

**Remark** The delay times can be changed within the range listed in **Table 3**. For details, please contact our sales representatives.

<sup>\*2.</sup> Refer to Caution 3 of "4. External components list" in "■ Examples of Application Circuit Added the Discharge Overcurrent Protection Function" for details.

## **■** Pin Configuration

## 1. SNT-6A

Top view



Figure 2

Table 4

Pin No.	Symbol	Description			
1	VM	Input pin for external negative voltage			
2	со	Connection pin of charge control FET gate (CMOS output)			
3	DO	Connection pin of discharge control FET gate (CMOS output)			
4	VSS	Input pin for negative power supply			
5	VDD	Input pin for positive power supply			
6	VINI	Overcurrent detection pin			

## ■ Absolute Maximum Ratings

Table 5

(Ta = +25°C unless otherwise specified)

Item	Symbol	Applied Pin	Absolute Maximum Rating	Unit
Input voltage between VDD pin and VSS pin	V <sub>DS</sub>	VDD	$V_{SS}-0.3$ to $V_{SS}+6$	V
VINI pin input voltage	V <sub>VINI</sub>	VINI	$V_{DD}-6$ to $V_{DD}+0.3$	<b>V</b>
VM pin input voltage	V <sub>VM</sub>	VM	$V_{DD} - 28 \text{ to } V_{DD} + 0.3$	V
DO pin output voltage	$V_{DO}$	DO	$V_{SS} - 0.3$ to $V_{DD} + 0.3$	V
CO pin output voltage	Vco	СО	$V_{DD}-28$ to $V_{DD}+0.3$	V
Operation ambient temperature	T <sub>opr</sub>	_	-40 to +85	°C
Storage temperature	T <sub>stg</sub>	_	-55 to +125	°C

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

## **■** Thermal Resistance Value

Table 6

Item	Symbol	Condition		Min.	Тур.	Max.	Unit
			Board A	I	224	I	°C/W
	θја		Board B	_	176	_	°C/W
Junction-to-ambient thermal resistance*1		SNT-6A	Board C	_	_	_	°C/W
			Board D	_	_	_	°C/W
			Board E	_	_	_	°C/W

<sup>\*1.</sup> Test environment: compliance with JEDEC STANDARD JESD51-2A

Remark Refer to "■ Power Dissipation" and "Test Board" for details.

## **■** Electrical Characteristics

## 1. Ta = +25°C

Table 7

(Ta = +25°C unless otherwise specified)

ltem	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Detection Voltage		L	<u>I</u>		<u>I</u>		
Discharge overcurrent detection voltage 1	$V_{DIOV1}$	_	V <sub>DIOV1</sub> – 0.0015	$V_{DIOV1}$	V <sub>DIOV1</sub> + 0.0015	V	1
Discharge overcurrent detection voltage 2	V <sub>DIOV2</sub>	_	V <sub>DIOV2</sub> – 0.003	$V_{\text{DIOV2}}$	V <sub>DIOV2</sub> + 0.003	V	1
Load short-circuiting detection voltage	V <sub>SHORT</sub>	_	V <sub>SHORT</sub> – 0.005	V <sub>SHORT</sub>	V <sub>SHORT</sub> + 0.005	V	1
Charge overcurrent detection voltage	V <sub>CIOV</sub>	_	V <sub>CIOV</sub> – 0.0015	V <sub>CIOV</sub>	V <sub>CIOV</sub> + 0.0015	V	1
Discharge overcurrent release voltage	$V_{RIOV}$	V <sub>DD</sub> = 3.4 V	$V_{DD} \times 0.77$	$V_{DD} \times 0.80$	$V_{DD} \times 0.83$	V	1
Internal Resistance							
Resistance between VDD pin and VM pin	$R_{VMD}$	$V_{DD} = 1.8 \text{ V}, V_{VM} = 0 \text{ V}$	500	1250	2500	kΩ	2
Resistance between VM pin and VSS pin	R <sub>VMS</sub>	$V_{DD} = 3.4 \text{ V}, V_{VM} = 1.0 \text{ V}$	5	10	15	kΩ	2
Input Voltage							
Operation voltage between VDD pin and VSS pin	$V_{DSOP1}$	-	1.5	-	6.0	٧	-
Operation voltage between VDD pin and VM pin	V <sub>DSOP2</sub>	-	1.5	_	28	٧	-
Input Current							
Current consumption during operation	I <sub>OPE</sub>	$V_{DD} = 3.4 \text{ V}, V_{VM} = 0 \text{ V}$	_	2.0	4.0	μΑ	2
Output Resistance			_		_		
CO pin resistance "H"	R <sub>COH</sub>	-	5	10	20	kΩ	3
CO pin resistance "L"	R <sub>COL</sub>	_	5	10	20	kΩ	3
DO pin resistance "H"	R <sub>DOH</sub>	-	5	10	20	kΩ	3
DO pin resistance "L"	$R_{DOL}$	-	1	2	4	kΩ	3
Delay Time							
Discharge overcurrent detection delay time 1	4	_	$t_{DIOV1} \times 0.75$	t <sub>DIOV1</sub>	$t_{DIOV1} \times 1.25$	_	4
Discharge overcurrent detection delay time 1	t <sub>DIOV1</sub>	Ta = $-20^{\circ}$ C to $+60^{\circ}$ C*1	$t_{DIOV1} \times 0.65$	t <sub>DIOV1</sub>	$t_{DIOV1} \times 1.35$	_	4
Discharge overcurrent detection delay time 2	t <sub>DIOV2</sub>	-	$t_{DIOV2} \times 0.7$	t <sub>DIOV2</sub>	$t_{DIOV2} \times 1.3$	_	4
Load short-circuiting detection delay time	t <sub>SHORT</sub>	-	$t_{\text{SHORT}} \times 0.7$	t <sub>SHORT</sub>	$t_{SHORT} \times 1.3$	_	4
Charge overcurrent detection delay time	t <sub>CIOV</sub>	-	$t_{\text{CIOV}} \times 0.7$	t <sub>CIOV</sub>	$t_{\text{CIOV}} \times 1.3$	_	4

<sup>\*1.</sup> Since products are not screened at high and low temperature, the specification for this temperature range is guaranteed by design, not tested in production.

## 2. Ta = $-40^{\circ}$ C to $+85^{\circ}$ C<sup>\*1</sup>

Table 8

(Ta = -40°C to +85°C<sup>\*1</sup> unless otherwise specified)

			(14 - <del>1</del> 0 0	10 100 0	urness onlerwis	oc op	somea)
ltem	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Detection Voltage							
Discharge overcurrent detection voltage 1	V <sub>DIOV1</sub>	_	V <sub>DIOV1</sub> – 0.002	V <sub>DIOV1</sub>	$V_{DIOV1} + 0.002$	V	1
Discharge overcurrent detection voltage 2	$V_{DIOV2}$	_	$V_{\text{DIOV2}} - 0.003$	$V_{DIOV2}$	$V_{DIOV2} + 0.003$	V	1
Load short-circuiting detection voltage	V <sub>SHORT</sub>	-	V <sub>SHORT</sub> – 0.005	V <sub>SHORT</sub>	V <sub>SHORT</sub> + 0.005	V	1
Charge overcurrent detection voltage	V <sub>CIOV</sub>	_	V <sub>CIOV</sub> - 0.002	V <sub>CIOV</sub>	V <sub>CIOV</sub> +0.002	V	1
Discharge overcurrent release voltage	V <sub>RIOV</sub>	V <sub>DD</sub> = 3.4 V	$V_{DD} \times 0.77$	$V_{DD} \times 0.80$	$V_{DD} \times 0.83$	V	1
Internal Resistance							
Resistance between VDD pin and VM pin	R <sub>VMD</sub>	$V_{DD} = 1.8 \text{ V}, V_{VM} = 0 \text{ V}$	250	1250	3500	kΩ	2
Resistance between VM pin and VSS pin	R <sub>VMS</sub>	$V_{DD} = 3.4 \text{ V}, V_{VM} = 1.0 \text{ V}$	3.5	10	20	kΩ	2
Input Voltage							
Operation voltage between VDD pin and VSS pin	V <sub>DSOP1</sub>	-	1.5	-	6.0	٧	_
Operation voltage between VDD pin and VM pin	V <sub>DSOP2</sub>	-	1.5	_	28	٧	-
Input Current							
Current consumption during operation	I <sub>OPE</sub>	$V_{DD} = 3.4 \text{ V}, V_{VM} = 0 \text{ V}$	_	2.0	5.0	μΑ	2
Output Resistance							
CO pin resistance "H"	R <sub>COH</sub>	_	2.5	10	30	kΩ	3
CO pin resistance "L"	R <sub>COL</sub>	_	2.5	10	30	kΩ	3
DO pin resistance "H"	R <sub>DOH</sub>	-	2.5	10	30	kΩ	3
DO pin resistance "L"	R <sub>DOL</sub>	-	0.5	2	6	kΩ	3
Delay Time			<u> </u>		<u> </u>		
Discharge overcurrent detection delay time 1	t <sub>DIOV1</sub>	_	$t_{\text{DIOV1}} \times 0.4$	t <sub>DIOV1</sub>	$t_{DIOV1} \times 1.6$	_	4
Discharge overcurrent detection delay time 2	t <sub>DIOV2</sub>	-	$t_{DIOV2} \times 0.4$	t <sub>DIOV2</sub>	$t_{DIOV2} \times 1.6$	_	4
Load short-circuiting detection delay time	t <sub>SHORT</sub>	-	$t_{\text{SHORT}} \times 0.4$	t <sub>SHORT</sub>	$t_{SHORT} \times 1.6$	_	4
Charge overcurrent detection delay time	t <sub>CIOV</sub>	_	$t_{\text{CIOV}} \times 0.4$	t <sub>CIOV</sub>	$t_{\text{CIOV}} \times 1.6$	_	4

<sup>\*1.</sup> Since products are not screened at high and low temperature, the specification for this temperature range is guaranteed by design, not tested in production.

#### ■ Test Circuits

Caution Unless otherwise specified, the output voltage levels "H" and "L" at CO pin ( $V_{CO}$ ) and DO pin ( $V_{DO}$ ) are judged by the threshold voltage (1.0 V) of the N-channel FET. Judge the CO pin level with respect to  $V_{VM}$  and the DO pin level with respect to  $V_{SS}$ .

# 1. Discharge overcurrent detection voltage 1, discharge overcurrent release voltage (Test circuit 1)

#### 1. 1 Release voltage of discharge overcurrent status "VDIOV1"

Discharge overcurrent detection voltage 1 ( $V_{DIOV1}$ ) is defined as the voltage V5 whose delay time for changing  $V_{DO}$  from "H" to "L" is discharge overcurrent detection delay time 1 ( $t_{DIOV1}$ ) when the voltage V5 is increased from the starting conditions of V1 = 3.4 V, V2 = 1.4 V, V5 = 0 V.  $V_{DO}$  goes from "L" to "H" when setting V2 = 3.4 V and when the voltage V2 is then gradually decreased to  $V_{DIOV1}$  typ. or lower.

#### 1. 2 Release voltage of discharge overcurrent status "VRIOV"

 $V_{DIOV1}$  is defined as the voltage V5 whose delay time for changing  $V_{DO}$  from "H" to "L" is  $t_{DIOV1}$  when the voltage V5 is increased from the starting conditions of V1 = 3.4 V, V2 = 1.4 V, V5 = 0 V. Discharge overcurrent release voltage ( $V_{RIOV}$ ) is defined as the voltage V2 at which  $V_{DO}$  goes from "L" to "H" when setting V2 = 3.4 V and when the voltage V2 is then gradually decreased.

# 2. Discharge overcurrent detection voltage 2 (Test circuit 1)

Discharge overcurrent detection voltage 2 ( $V_{DIOV2}$ ) is defined as the voltage V5 whose delay time for changing  $V_{DO}$  from "H" to "L" is discharge overcurrent detection delay time 2 ( $t_{DIOV2}$ ) when the voltage V5 is increased after setting V1 = 3.4 V, V2 = 1.4 V, V5 = 0 V.

### Load short-circuiting detection voltage (Test circuit 1)

Load short-circuiting detection voltage ( $V_{SHORT}$ ) is defined as the voltage V5 whose delay time for changing  $V_{DO}$  from "H" to "L" is load short-circuiting detection delay time ( $t_{SHORT}$ ) when the voltage V5 is increased after setting V1 = 3.4 V, V2 = 1.4 V, V5 = 0 V.

# 4. Charge overcurrent detection voltage (Test circuit 1)

Charge overcurrent detection voltage ( $V_{CIOV}$ ) is defined as the voltage V5 whose delay time for changing  $V_{CO}$  from "H" to "L" is charge overcurrent detection delay time ( $t_{CIOV}$ ) when the voltage V5 is decreased after setting V1 = 3.4 V, V2 = V5 = 0 V.

## Current consumption during operation (Test circuit 2)

The current consumption during operation ( $I_{OPE}$ ) is the current that flows through the VDD pin ( $I_{DD}$ ) after setting V1 = 3.4 V, V2 = V5 = 0 V.

# 6. Resistance between VDD pin and VM pin (Test circuit 2)

R<sub>VMD</sub> is the resistance between VDD pin and VM pin under the set conditions of V1 = 1.8 V, V2 = V5 = 0 V.

# 7. Resistance between VM pin and VSS pin (Test circuit 2)

 $R_{VMS}$  is the resistance between VM pin and VSS pin when the voltage V5 is decreased to 0 V after setting V1 = 3.4 V, V2 = V5 = 1.0 V.

# 8. CO pin resistance "H" (Test circuit 3)

The CO pin resistance "H" (R<sub>COH</sub>) is the resistance between VDD pin and CO pin under the set conditions of V1 = 3.4 V, V2 = V5 = 0 V, V3 = 3.0 V.

## CO pin resistance "L" (Test circuit 3)

The CO pin resistance "L" ( $R_{COL}$ ) is the resistance between VM pin and CO pin under the set conditions of V1 = 4.7 V, V2 = V5 = 0 V, V3 = 0.4 V.

### 10. DO pin resistance "H"

#### (Test circuit 3)

The DO pin resistance "H" ( $R_{DOH}$ ) is the resistance between VDD pin and DO pin under the set conditions of V1 = 3.4 V, V2 = V5 = 0 V, V4 = 3.0 V.

## 11. DO pin resistance "L"

#### (Test circuit 3)

The DO pin resistance "L" ( $R_{DOL}$ ) is the resistance between VSS pin and DO pin under the set conditions of V1 = 1.8 V, V2 = V5 = 0 V, V4 = 0.4 V.

# 12. Discharge overcurrent detection delay time 1 (Test circuit 4)

Increase the voltage V5 after setting V1 = 3.4 V, V2 = 1.4 V, V5 = 0 V. The discharge overcurrent detection delay time 1 ( $t_{DIOV1}$ ) is the time period from when the voltage V5 exceeds  $V_{DIOV1}$  until  $V_{DO}$  goes to "L".

# 13. Discharge overcurrent detection delay time 2 (Test circuit 4)

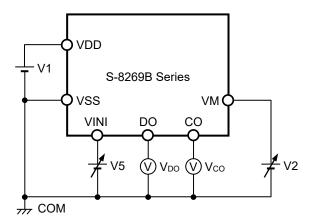
Increase the voltage V5 after setting V1 = 3.4 V, V2 = 1.4 V, V5 = 0 V. The discharge overcurrent detection delay time 2 ( $t_{DIOV2}$ ) is the time period from when the voltage V5 exceeds  $V_{DIOV2}$  until  $V_{DO}$  goes to "L".

# 14. Load short-circuiting detection delay time (Test circuit 4)

Increase the voltage V5 after setting V1 = 3.4 V, V2 = 1.4 V, V5 = 0 V. The load short-circuiting detection delay time ( $t_{SHORT}$ ) is the time period from when the voltage V5 exceeds  $V_{SHORT}$  until  $V_{DO}$  goes to "L".

### Charge overcurrent detection delay time (Test circuit 4)

Decrease the voltage V5 after setting V1 = 3.4 V, V2 = V5 = 0 V. The charge overcurrent detection delay time  $(t_{CIOV})$  is the time period from when the voltage V5 falls below  $V_{CIOV}$  until  $V_{CO}$  goes to "L".



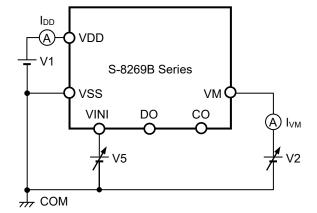


Figure 3 Test Circuit 1

Figure 4 Test Circuit 2

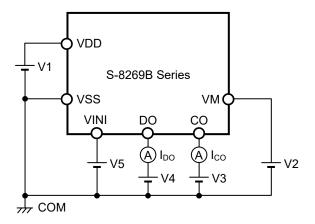


Figure 5 Test Circuit 3

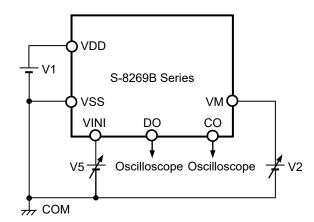


Figure 6 Test Circuit 4

## Operation

Remark Refer to "Examples of Application Circuit Added the Discharge Overcurrent Protection Function".

#### 1. Normal status

The S-8269B Series monitors the voltage between VINI pin and VSS pin to control charging and discharging. When the VINI pin voltage is in the range from charge overcurrent detection voltage (V<sub>CIOV</sub>) to discharge overcurrent detection voltage 1 (V<sub>DIOV1</sub>), the S-8269B Series turns both the charge and discharge control FETs on. This condition is called the normal status, and in this condition charging and discharging can be carried out freely.

The resistance between VDD pin and VM pin ( $R_{VMD}$ ), and the resistance between VM pin and VSS pin ( $R_{VMS}$ ) are not connected in the normal status.

Caution After the battery is connected, discharging may not be carried out. In this case, the S-8269B Series returns to the normal status by connecting a charger.

# 2. Discharge overcurrent status (discharge overcurrent 1, discharge overcurrent 2, load short-circuiting)

When a battery in the normal status is in the status where the VINI pin voltage is equal to or higher than V<sub>DIOV1</sub> because the discharge current is equal to or higher than the specified value and the status lasts for the discharge overcurrent detection delay time 1 (t<sub>DIOV1</sub>) or longer, the discharge control FET is turned off and discharging is stopped. This status is called the discharge overcurrent status.

#### 2. 1 Release voltage of discharge overcurrent status "VDIOV1"

Under the discharge overcurrent status, VM pin and VSS pin are shorted by  $R_{VMS}$  in the S-8269B Series. However, the VM pin voltage is the VDD pin voltage due to the load as long as the load is connected. When the load is disconnected, VM pin voltage returns to the VSS pin voltage. When the VM pin voltage returns to  $V_{DIOV1}$  or lower, the S-8269B Series releases the discharge overcurrent status.

 $R_{\text{VMD}}$  is not connected in the discharge overcurrent status.

#### 2. 2 Release voltage of discharge overcurrent status "VRIOV"

Under the discharge overcurrent status, VM pin and VSS pin are shorted by  $R_{VMS}$  in the S-8269B Series. However, the VM pin voltage is the VDD pin voltage due to the load as long as the load is connected. When the load is disconnected, VM pin voltage returns to the VSS pin voltage. When the VM pin voltage returns to  $V_{RIOV}$  or lower, the S-8269B Series releases the discharge overcurrent status.

R<sub>VMD</sub> is not connected in the discharge overcurrent status.

### 3. Charge overcurrent status

When a battery in the normal status is in the status where the VINI pin voltage is equal to or lower than  $V_{CIOV}$  because the charge current is equal to or higher than the specified value and the status lasts for the charge overcurrent detection delay time ( $t_{CIOV}$ ) or longer, the charge control FET is turned off and charging is stopped. This status is called the charge overcurrent status.

The S-8269B Series releases the charge overcurrent status when the discharge current flows and the VM pin voltage is 0.35 V typ. or higher by removing the charger.

Under the charge overcurrent status, VDD pin and VM pin are shorted by  $R_{VMD}$  in the S-8269B Series. The VM pin is pulled up by  $R_{VMD}$ .

R<sub>VMS</sub> is not connected in the charge overcurrent status.

## 4. Delay circuit

The detection delay times are determined by dividing a clock of approximately 4 kHz by the counter.

**Remark** t<sub>DIOV1</sub>, t<sub>DIOV2</sub> and t<sub>SHORT</sub> start when V<sub>DIOV1</sub> is detected. When V<sub>DIOV2</sub> or V<sub>SHORT</sub> is detected over t<sub>DIOV2</sub> or t<sub>SHORT</sub> after the detection of V<sub>DIOV1</sub>, the S-8269B Series turns the discharge control FET off within t<sub>DIOV2</sub> or t<sub>SHORT</sub> of each detection.

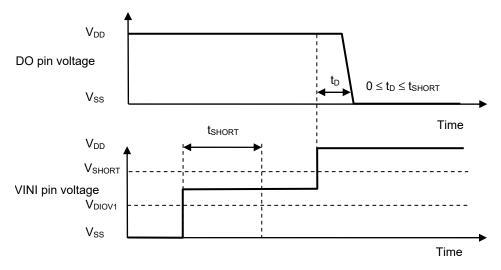
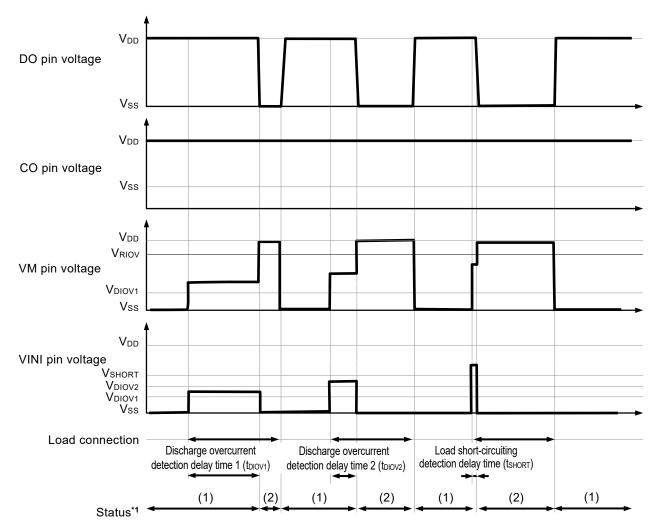


Figure 7

## **■** Timing Charts

## 1. Discharge overcurrent detection

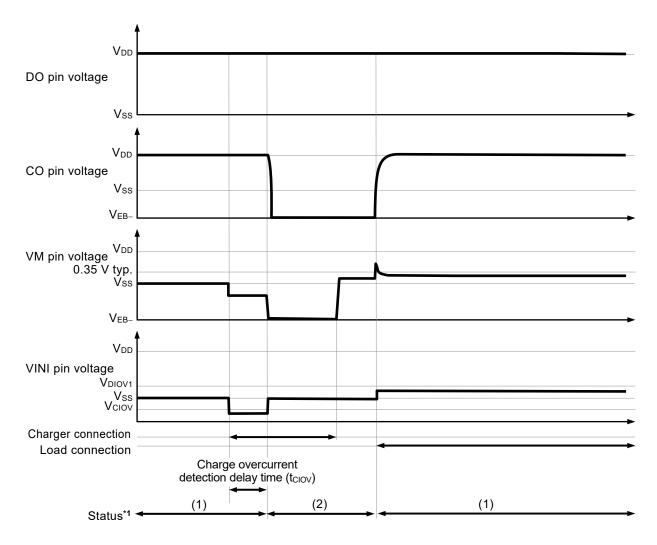


\*1. (1): Normal status

(2): Discharge overcurrent status

Figure 8

## 2. Charge overcurrent detection



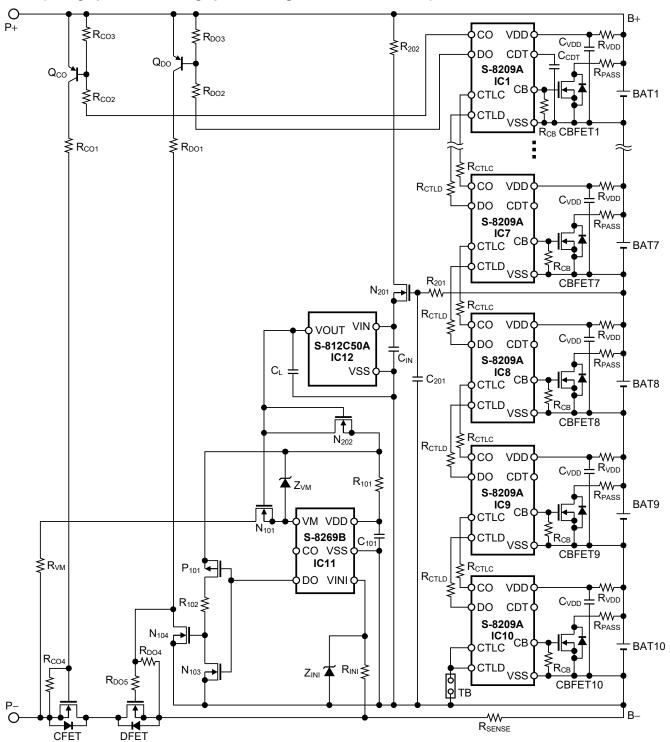
\*1. (1): Normal status

(2): Charge overcurrent status

Figure 9

## ■ Examples of Application Circuit Added the Discharge Overcurrent Protection Function

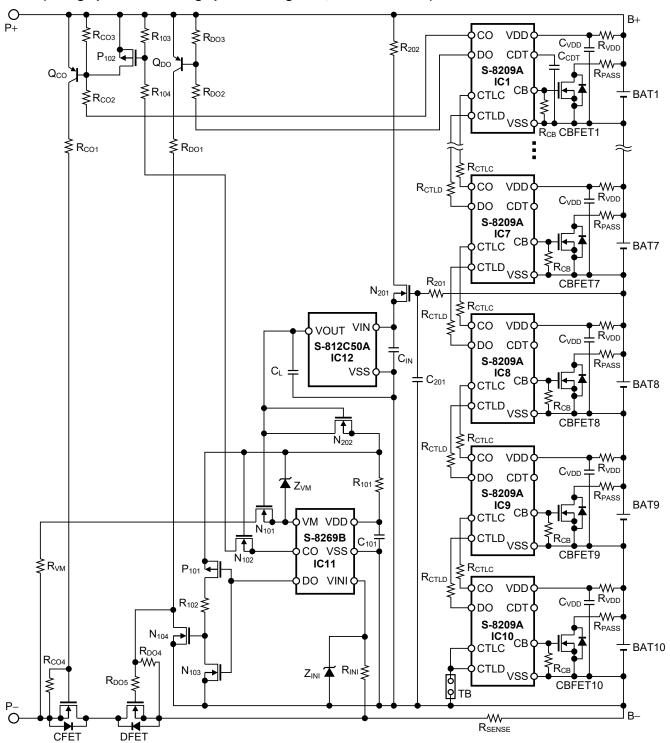
1. 10-serial cell protection circuit added the discharge overcurrent protection function (Charge pin and discharge pin are integrated, S-8269B Series)



Remark Refer to "4. External components list" for constants of external components.

Figure 10

2. 10-serial cell protection circuit added the charge and discharge overcurrent protection functions (Charge pin and discharge pin are integrated, S-8269B Series)

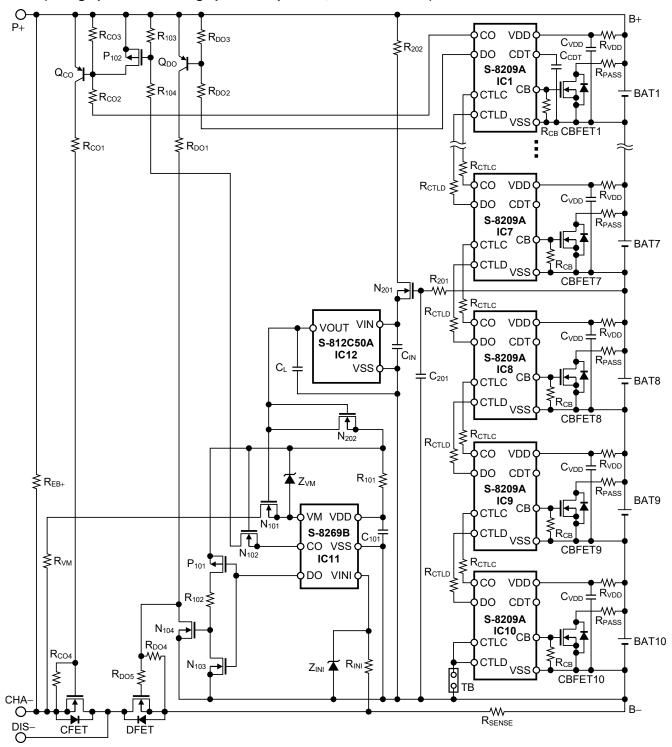


**Remark** Refer to "4. External components list" for constants of external components.

Figure 11

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3. 10-serial cell protection circuit added the charge and discharge overcurrent protection functions (Charge pin and discharge pin are separated, S-8269B Series)



Remark Refer to "4. External components list" for constants of external components.

Figure 12

## 4. External components list

Table 9 shows external components used in the connection examples in Figure 10 to Figure 12.

Table 9

Symbol	Typical	Unit	Components name	Maker	Remark
IC1 to IC10	_	_	S-8209A	ABLIC Inc.	Necessary
IC11	_	_	S-8269B*1	ABLIC Inc.	Necessary
IC12	_	_	S-812C50A	ABLIC Inc.	Necessary
CBFET1 to CBFET10	-	_	-	_	User setting
CFET	_		_	_	User setting
DFET	_	_	_	_	User setting
Ссрт	_	_	_	_	User setting
Cin	0.1	μF	GRM188	Murata Manufacturing Co., Ltd.	User setting
CL	0.1	μF	GRM188	Murata Manufacturing Co., Ltd.	User setting
C <sub>VDD</sub>	0.1	μF	GRM188	Murata Manufacturing Co., Ltd.	Recommended
C <sub>101</sub>	0.1	μF	-		Recommended
C <sub>201</sub> *2	1	μF	_	_	Recommended
N <sub>101</sub>	_		SSM3K7002KF	Toshiba Electronic Devices & Storage Corporation	Recommended
N <sub>102</sub>	_	_	SSM3K7002KF	Toshiba Electronic Devices & Storage Corporation	Recommended
N <sub>103</sub>	_	_	SSM3K7002KF	Toshiba Electronic Devices & Storage Corporation	Recommended
N <sub>104</sub>	_	_	SSM3K7002KF	Toshiba Electronic Devices & Storage Corporation	Recommended
N <sub>201</sub>	_	_	SSM3K7002KF	Toshiba Electronic Devices & Storage Corporation	Recommended
N <sub>202</sub>	_	_	SSM3K7002KF	Toshiba Electronic Devices & Storage Corporation	Recommended
P <sub>101</sub>	_	_	SSM3J168F	Toshiba Electronic Devices & Storage Corporation	Recommended
P <sub>102</sub>	_	_	SSM3J168F	Toshiba Electronic Devices & Storage Corporation	Recommended
Qco	PNP	_	2SB1198K	ROHM CO., LTD.	Recommended
Q <sub>DO</sub>	PNP	_	2SB1198K	ROHM CO., LTD.	Recommended
RcB	10	ΜΩ	MCR03	ROHM CO., LTD.	Recommended
Rco1*3	-	-	_		User setting
Rco2	510	kΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>CO3</sub>	1	MΩ	MCR03	ROHM CO., LTD.	Recommended
Rco4	1	MΩ	MCR03	ROHM CO., LTD.	Recommended
Rctlc*4	1	kΩ	MCR03	ROHM CO., LTD.	Recommended
RCTLD*4	1	kΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>DO1</sub> *3	_	_	_	_	User setting
R <sub>DO2</sub>	510	kΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>DO3</sub>	1	ΜΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>DO4</sub>	1	MΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>D05</sub>	_	_	_	_	User setting
R <sub>EB+</sub>	10	МΩ	MCR03	ROHM CO., LTD.	Recommended
Rini	1	kΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>PASS</sub> *5	_	_	_	_	User setting
Rsense*5	_	_	_	-	User setting
RVDD	470	Ω	MCR03	ROHM CO., LTD.	Recommended
RvM	1	kΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>101</sub>	470	Ω	MCR03	ROHM CO., LTD.	Recommended
R <sub>102</sub>	5.1	kΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>103</sub>	1	MΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>104</sub>	510	kΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>201</sub> *2	1	kΩ	MCR03	ROHM CO., LTD.	Recommended
R <sub>202</sub>	100	Ω	MCR03	ROHM CO., LTD.	Recommended
TB*6	-		_	<del>-</del>	User setting
Z <sub>INI</sub>	_	_	UFZV3.6B	ROHM CO., LTD.	Recommended
Z <sub>VM</sub> *7	_	_	1SMB5930B	Diodes Incorporated	User setting

- \*1. Select this product according to the overcurrent detection voltage that you will use.
- \*2. At the moment when the S-8269B Series detects the overcurrent and turns off DFET, a spike voltage generated in BAT8 may result in transient change of the power supply of the S-8269B Series through  $N_{201}$  and cause the S-8269B Series to malfunction for overcurrent detection. This phenomenon can be prevented by setting  $C_{201}$  and  $R_{201}$ . The constant of  $C_{201}$  and  $R_{201}$  is normally 1  $\mu$ F  $\times$  1 k $\Omega$  = 1 mF  $\times$   $\Omega$ . However, since the spike voltage generated in BAT8 differs depending on each application, perform thorough evaluation about the power supply transient change and overcurrent protection function of the S-8269B Series using the actual application to set  $C_{201}$  and  $R_{201}$ .
- \*3. Set the resistance with attention to VGS rated value of FET.
- \*4. In order to prevent from damage when an overvoltage is applied to the IC, select R<sub>CTLC</sub> and R<sub>CTLD</sub> from 1 k $\Omega$  to 100 k $\Omega$ .
- \*5. Pay attention to the rated electric powers.
- \*6. TB: Thermal Breaker
  - When a TB is not necessary, connect the same protection resistor as RCTLC or RCTLD.
- \*7. When building a protection circuit for 10-serial or more cells, connect Z<sub>VM</sub> so that the VM pin voltage does not exceed the absolute maximum rating.
- Caution 1. The constants may be changed without notice.
  - 2. It has not been confirmed whether the operation is normal or not in circuits other than the connection examples. In addition, the connection examples and the constants do not guarantee proper operation. Perform thorough evaluation using the actual application to set the constants.
  - 3. Set  $V_{VM}$  as follows to release the S-8269B Series from the discharge overcurrent status when a load is open.
    - "1. 10-serial cell protection circuit added the discharge overcurrent protection function (Charge pin and discharge pin are integrated, S-8269B Series)" or "2. 10-serial cell protection circuit added the charge and discharge overcurrent protection functions (Charge pin and discharge pin are integrated, S-8269B Series)"

$$V_{VM} = V_{P+} \times \frac{R_{VMS}}{R_{CO1} + R_{CO4} + R_{VM} + R_{VMS}} \le V_{RIOV} \text{ or } V_{DIOV1}$$

• "3. 10-serial cell protection circuit added the charge and discharge overcurrent protection functions (Charge pin and discharge pin are separated, S-8269B Series)"

$$V_{VM} = V_{P+} \times \frac{R_{VMS}}{\frac{R_{EB+} \times (R_{CO1} + R_{CO4})}{R_{EB+} + R_{CO1} + R_{CO4}}} + R_{VM} + R_{VMS}$$

Remark V<sub>P+</sub>: P+ pin voltage

Rev.1.3\_00

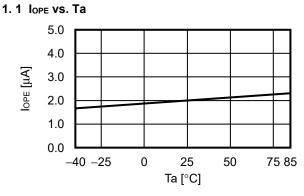
#### Precautions

- The application conditions for the input voltage, output voltage, and load current should not exceed the power dissipation.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- ABLIC Inc. claims no responsibility for any disputes arising out of or in connection with any infringement by products including this IC of patents owned by a third party.

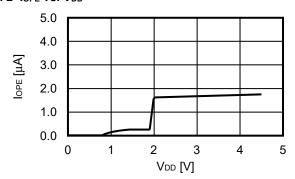
## ■ Characteristics (Typical Data)

## 1. Current consumption

#### . . . –

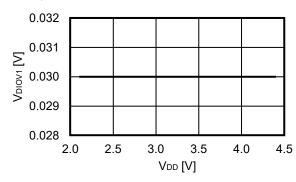


#### 1. 2 IOPE VS. VDD

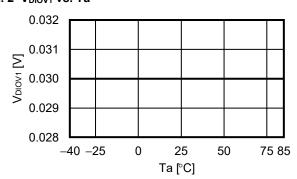


## 2. Detection voltage

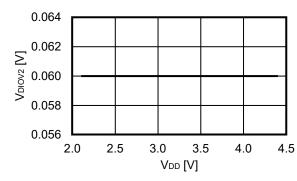
## 2. 1 $V_{DIOV1}$ vs. $V_{DD}$



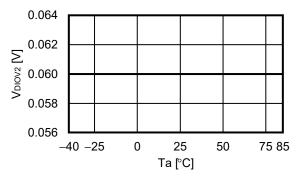
## 2. 2 $V_{\text{DIOV1}}$ vs. Ta



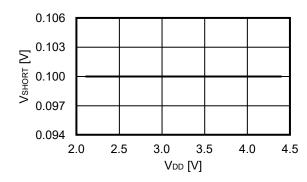
2. 3 VDIOV2 VS. VDD



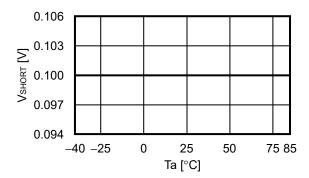
2. 4 V<sub>DIOV2</sub> vs. Ta



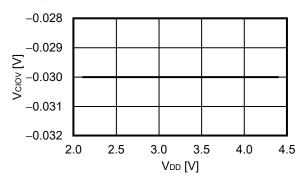
## 2. 5 VSHORT VS. VDD



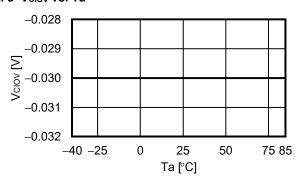
2. 6 V<sub>SHORT</sub> vs. Ta



2. 7 Vciov vs. VDD



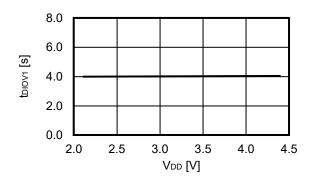
2. 8 Vciov vs. Ta



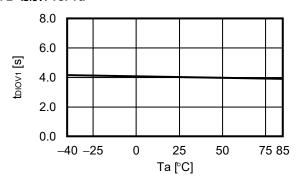
22 ABLIC Inc.

## 3. Delay time

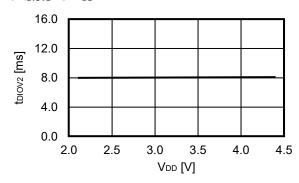
#### 3. 1 tDIOV1 vs. VDD



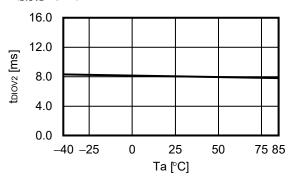
3. 2 t<sub>DIOV1</sub> vs. Ta



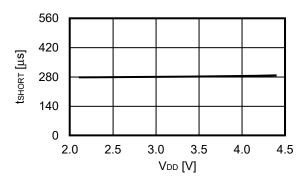
3. 3 tDIOV2 vs. VDD



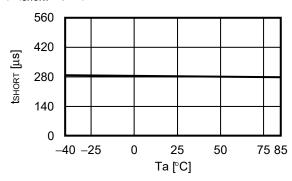
3. 4 t<sub>DIOV2</sub> vs. Ta



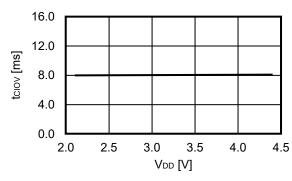
3. 5 tshort vs. VDD



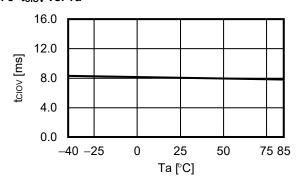
3. 6 tshort vs. Ta



3. 7  $t_{\text{CIOV}}$  vs.  $V_{\text{DD}}$ 

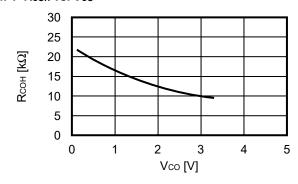


3.8 t<sub>ClOV</sub> vs. Ta

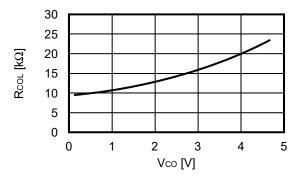


## 4. Output resistance

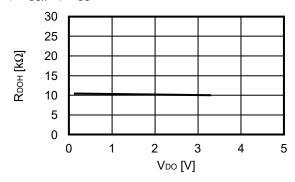
## 4. 1 Rcon vs. Vco



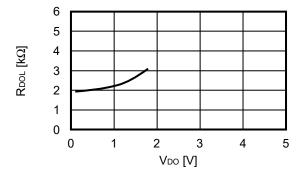
4. 2 Rcol vs. Vco



4. 3 RDOH vs.  $V_{DO}$ 



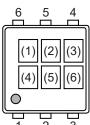
4. 4 RDOL VS. VDO



## ■ Marking Specifications

## 1. SNT-6A

Top view



(1) to (3): Product code (refer to **Product name vs. Product code**)

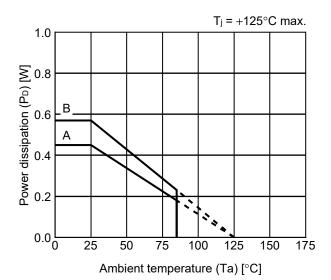
(4) to (6): Lot number

#### Product name vs. Product code

Dua di sat Nama a	Product Code				
Product Name	(1)	(2)	(3)		
S-8269BAA-I6T1U	7	8	Α		
S-8269BAB-I6T1U	7	8	В		
S-8269BAC-I6T1U	7	8	С		
S-8269BAD-I6T1U	7	8	D		

## **■** Power Dissipation

## SNT-6A

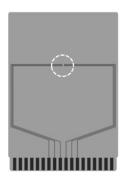


Board	Power Dissipation (P <sub>D</sub> )
A	0.45 W
В	0.57 W
С	_
D	_
Е	_

# **SNT-6A** Test Board

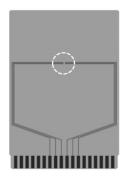
## (1) Board A





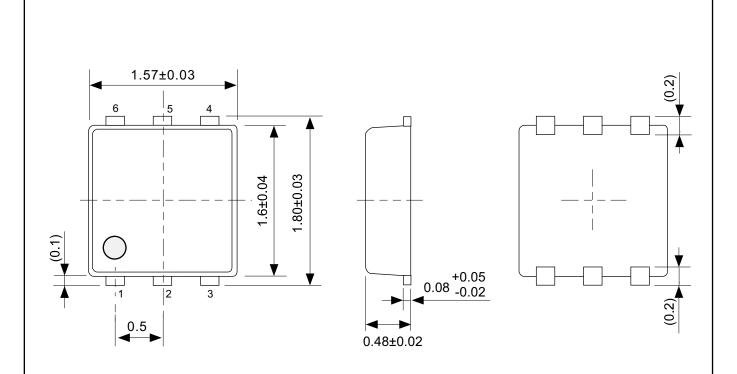
Item		Specification			
Size [mm]		114.3 x 76.2 x t1.6			
Material		FR-4			
Number of copper foil layer		2			
	1	Land pattern and wiring for testing: t0.070			
Coppor foil layer [mm]	2	-			
Copper foil layer [mm]	3	-			
	4	74.2 x 74.2 x t0.070			
Thermal via		-			

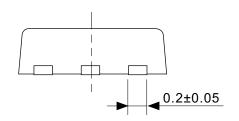
## (2) Board B



Item		Specification		
Size [mm]		114.3 x 76.2 x t1.6		
Material		FR-4		
Number of copper foil layer		4		
Copper foil layer [mm]	1	Land pattern and wiring for testing: t0.070		
	2	74.2 x 74.2 x t0.035		
	3	74.2 x 74.2 x t0.035		
	4	74.2 x 74.2 x t0.070		
Thermal via		-		

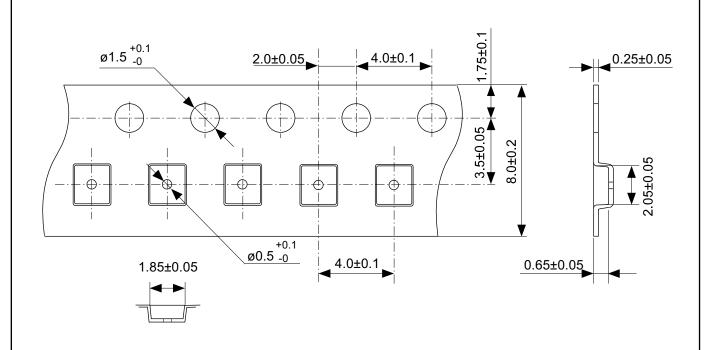
No. SNT6A-A-Board-SD-1.0

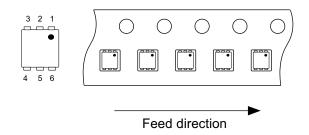




## No. PG006-A-P-SD-2.1

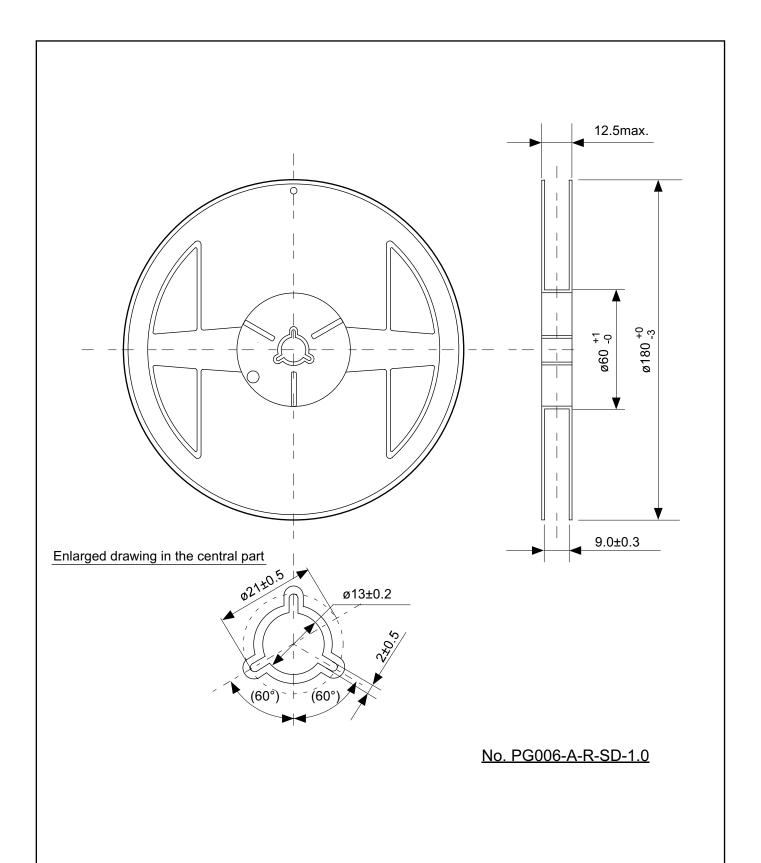
TITLE	SNT-6A-A-PKG Dimensions		
No.	PG006-A-P-SD-2.1		
ANGLE	<b>\$</b> E3		
UNIT	mm		
ABLIC Inc.			



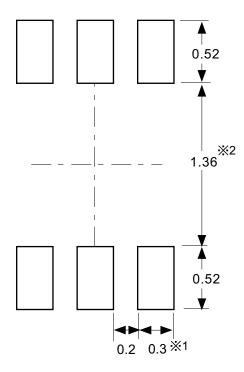


## No. PG006-A-C-SD-2.0

TITLE	SNT-6A-A-Carrier Tape				
No.	PG006-A-C-SD-2.0				
ANGLE					
UNIT	mm				
ABLIC Inc.					



TITLE	SNT-6A-A-Reel			
No.	PG006-A-R-SD-1.0			
ANGLE		QTY.	5,000	
UNIT	mm			
ABLIC Inc.				



%1. ランドパターンの幅に注意してください (0.25 mm min. / 0.30 mm typ.)。 %2. パッケージ中央にランドパターンを広げないでください (1.30 mm ~ 1.40 mm)。

- 注意 1. パッケージのモールド樹脂下にシルク印刷やハンダ印刷などしないでください。
  - 2. パッケージ下の配線上のソルダーレジストなどの厚みをランドパターン表面から0.03 mm 以下にしてください。
  - 3. マスク開口サイズと開口位置はランドパターンと合わせてください。
  - 4. 詳細は "SNTパッケージ活用の手引き"を参照してください。
- ※1. Pay attention to the land pattern width (0.25 mm min. / 0.30 mm typ.).
- ※2. Do not widen the land pattern to the center of the package (1.30 mm ~ 1.40 mm).
- Caution 1. Do not do silkscreen printing and solder printing under the mold resin of the package.
  - 2. The thickness of the solder resist on the wire pattern under the package should be 0.03 mm or less from the land pattern surface.
  - 3. Match the mask aperture size and aperture position with the land pattern.
  - 4. Refer to "SNT Package User's Guide" for details.
- ※1. 请注意焊盘模式的宽度 (0.25 mm min. / 0.30 mm typ.)。
- ※2. 请勿向封装中间扩展焊盘模式 (1.30 mm ~ 1.40 mm)。
- 注意 1. 请勿在树脂型封装的下面印刷丝网、焊锡。
  - 2. 在封装下、布线上的阻焊膜厚度 (从焊盘模式表面起) 请控制在 0.03 mm 以下。
  - 3. 钢网的开口尺寸和开口位置请与焊盘模式对齐。
  - 4. 详细内容请参阅 "SNT 封装的应用指南"。

No. PG006-A-L-SD-4.1

TITLE	SNT-6A-A -Land Recommendation		
No.	PG006-A-L-SD-4.1		
ANGLE			
UNIT	mm		
ARLIC Inc			

ABLIC Inc.

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  - The entire system in which the products are used must be sufficiently evaluated and judged whether the products are allowed to apply for the system on customer's own responsibility.
- 10. The products are not designed to be radiation-proof. The necessary radiation measures should be taken in the product design by the customer depending on the intended use.
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S-8269BAB-I6T1U S-8269BAC-I6T1U S-8269AAA-A8T2U